


<b>Search Notes</b>  	<b>Application/Control No.</b>  10571061	<b>Applicant(s)/Patent Under Reexamination</b>  FUJINO ET AL.
	<b>Examiner</b>  KYOUNG LEE	<b>Art Unit</b>  2812

SEARCHED			
Class	Subclass	Date	Examiner
361	272, 302, 503	2/28/2008	KL

SEARCH NOTES		
Search Notes	Date	Examiner
text search (361/311, 502) , (438/253, 381, 393, 396), and (29/ 25.03)	2/28/2008	KL

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner
PGPUB	Text search	2/29/2008	KL